

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT

APPLICANT(S): Hiroyuki Yoshida ATTY. DOCKET NO.: 09792909-6113
SERIAL NO.: Unknown GROUP ART UNIT: Unknown
DATE FILED: February 15, 2005 EXAMINER: Unknown
INVENTION: "INSULATED GATE FIELD-EFFECT TRANSISTOR AND ITS
MANUFACTURING METHOD, AND IMAGING DEVICE AND ITS
MANUFACTURING METHOD"

Mail Stop: PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

S I R:

In accordance with the provisions of 37 C.F.R. § 1.56, Applicants request that citation and examination of the references identified on the attached PTO-1449 form, copies of which are enclosed herewith in accordance with 37 C.F.R. §1.98, be made during the course of examination of the above-referenced application for United States Letters Patent.

I. SUBMITTED US PATENT REFERENCES

	<u>Number</u>	<u>Inventor(s)</u>	<u>Date of Publication</u>
AA			

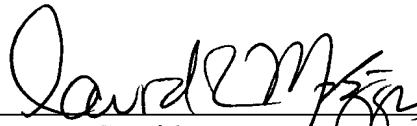
II. SUBMITTED FOREIGN PATENT REFERENCES

	<u>Number</u>	<u>Country</u>	<u>Date of Publication</u>
AH	JP2002-83888	Japan	March 22, 2002
AI	JP05-335564	Japan	December 17, 1993
AJ	EP 517164 A1	Europe	December 9, 1992
AK	JP07-297295	Japan	November 10, 1995
AL	JP2001-230406	Japan	August 24, 2001

III. OTHER ITEMS OF INFORMATIONIV. EXPLANATION OF RELEVANCE

The above-identified references were cited in the International Search Report of November 25, 2003, in counterpart PCT/JP03/10408. A copy of the International Search Report is submitted herewith.

Submitted by,



(Reg. 32,919)

David R. Metzger

SONNENSCHN NATH & ROSENTHAL LLP

P.O. Box 061080

Wacker Drive Station - Sears Tower

Chicago, IL 60606-1080

Telephone: 312/876-8000

Attorneys for Applicant(s)

Customer #26263

37 CFR 1.501
 INFORMATION DISCLOSURE STATEMENT
 IN A PATENT
 (use several sheets if necessary)

Docket No. 09792909-6112
 Serial No. 10/524749

Applicants:
 Hiroyuki Yoshida

Filing Date
 February 15, 2005

Group Art Unit

U.S. PATENT DOCUMENTS

Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AH	JP2002-8388	3-22-02	Japan			Abstract	
	AI	JP05-335564	12-17-93	Japan			Abstract	
	AJ	EP 517164	12-9-92	Europe				
	AK	JP07-297295	11-10-95	Japan			Abstract	
	AL	JP2001-230406	8-24-01	Japan			Abstract	
	AM							
	AN							
	AO							
	AP							
	AQ							
	AR							
	AS							
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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	AW	
	AX	
	AY	
	AZ	

Examiner

Date Considered

***EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.